

Substitute for Form 1449 A & B/PTO				Complete if Known	
INFORMATION DISCLOSURE STATEMENT BY APPLICANT				Application Number	Unassigned
				Confirmation Number	Unassigned
				Filing Date	June 23, 2005
				First Named Inventor	Tsuyoshi NAKANO
				Art Unit	Unassigned 2813
				Examiner Name	Unassigned
Sheet	1	of	1	Attorney Docket Number	Q88663

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(use as many sheets as necessary)</i>		Application Number	10/540,515
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Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.	Translation ⁶
MDH		J.W. Matthews et al., "Defects in Epitaxial Multilayers", <i>Journal of Crystal Growth</i> , Vol. 27, 1974, pp. 118-125	
J		J.W. Matthews et al., "Defects in Epitaxial Multilayers", <i>Journal of Crystal Growth</i> , Vol. 32, No. 2, 1976, pp. 265-273	

Examiner Signature	<u>Monica D. Larson</u>	Date Considered	1/20/06
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